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Giant Stark Effect Assisted Radio Frequency Energy Harvesting Using Atomically Thin Earth-Abundant Iron Sulphide (FeS₂)

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Abstract: The advancement in two-dimensional (2D) materials has led to the development of new charging methods in portable and wearable electronic devices. However, their charging methods are still confined to contact/wired mode. Radio Frequency (RF) energy harvesting exhibits the potential for extracting electrical power from the environment, benefiting from its limitless ambient availability and extended power transfer capabilities. This paper demonstrates the fabrication of an RF energy harvesting device using liquid phase exfoliated atomically thin earth-abundant pyrite ore (iron sulfide (FeS₂)). Owing to pyrite's unique semiconductor properties such as a very small narrow band gap (0.8 eV) and high carrier mobility (360 cm²V⁻¹s⁻¹), it is possible to make a Schottky junction with metal electrode. Hence, we fabricated a Schottky device employing Ti/2D-FeS₂/ITO configuration using drop casting methods. Electrical measurements reveal that the device has a low turn-on voltage of 0.18 V and a low Schottky barrier height of 0.14 eV. To substantiate the role of 2D-FeS₂, density functional theories (DFT) were performed revealing the impact of the giant Stark effect (GSE) in lowering the bandgap of 2D FeS₂. This insidious phenomenon of GSE in 2D-FeS₂ makes it an ideal material of choice for RF energy harvesting applications. The device we fabricated functions within the commercial frequency modulation broadband range and extends seamlessly into the very high-frequency radio spectrum. It generated a 1.5 V output voltage using commercial FM broadband frequencies, sufficient for charging a 1.5 F supercapacitor. Subsequent experimentation with a handheld walkie-talkie demonstrated that the device could achieve a maximum voltage of 3.5 V within the one-meter range, exhibiting an efficiency of 30%. The implications of this discovery suggest that 2D-FeS₂-based wireless energy-powered portable devices hold promise for healthcare/biomedical device applications, energy harvesting in remote areas, and regions affected by floods or natural disasters.

Keywords: Radiofrequency, Energy harvesting, 2D-FeS₂, Giant Stark effect, Density Functional Theory.

1 Introduction

The progress in electronics has given rise to the emergence of portable and wearable smart devices. However, their dependence on wired charging poses limitations such as immobility, safety concerns, costs, and scalability issues. In such contexts, wireless energy harvesting emerges as a promising alternative. Radiofrequency (RF) energy harvesting, in particular, is gaining traction with the rapid expansion of wireless telecommunication devices like Wi-Fi, cell phone towers, and radio broadcast stations. This system can capture RF signals from these sources and convert them into usable

direct current (DC) without requiring an external power source¹. At the core of an RF energy harvester lies the semiconductor responsible for rectifying high-frequency radio waves. High carrier mobility Schottky devices are typically necessary to ensure efficient high-frequency cut-off operation. RF energy harvesting has been shown to work on rigid substrates like silicon and group III-V compounds². Nevertheless, modifying the electronic characteristics of these materials, such as electron affinity, carrier mobility, and work function, may prove challenging. Consequently, their substantial size restricts their applicability to flexible devices. Graphene and other two-dimensional (2D) materials, such as tellurides³, metal oxides⁴, and transition metal dichalcogenides (TMDC)⁵, have received significant attention for their potential applications in sensing and energy harvesting⁶. Among them, TMDC⁵, metal oxides⁷ and tellurides³ have been reported as potential candidates for sensing, energy storage and energy harvesting applications. 2D materials have been well-established for piezoelectric, triboelectric and flexoelectric applications⁸. Altering the thickness of 2D materials allows for tuning properties like carrier mobility, work function, and band gap⁹.

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Recent studies have showcased RF energy harvesting utilising well-known van der Waals (vdW) materials such as MoS₂¹⁰, WSe₂¹¹, and MoSe₂¹². Vertical Schottky devices were fabricated using mechanical exfoliation and atomic layer deposition methods. However, the associated costs of device fabrication and material processing complexity have hindered their practical application. An intriguing alternative has emerged in the form of RF energy harvesting using naturally available lead sulphide (PbS)¹³. Obtaining a lower Schottky barrier and higher carrier mobility is of utmost importance in radio frequency applications. A lower barrier minimises energy loss, while higher mobility guarantees a strong response at high frequencies¹⁴. The device should have a low turn-on voltage and low series resistance for enhanced sensitivity. Most devices using the above materials have a high turn-on voltage and series resistance, limiting the efficiency since the received RF power will be relatively low. Developing a device with a low turn-on voltage without additional electronic components is advantageous for a miniaturised energy harvesting system¹⁵. In addition, given the environmental implications associated with the use of materials like selenides and lead, there is a necessity for exploring alternative eco-friendly materials to pave the way for a sustainable future. One such material of interest is Iron sulfide (FeS₂)/Pyrite.

FeS₂ exhibits two polymorphic phases, pyrite and marcasite. Among them pyrite also known as Fool's gold due to its pale-yellow appearance is the most abundant sulphide ore found in the earth's crust^{16,17}. They are usually found along with other sulphides or oxides in sedimentary and metamorphic rocks making them the best choice for environment-friendly, inexpensive and readily available material. Pyrite is primarily used for the production of sulphur dioxide for the paper industry and also for sulphuric acid production for fertilizers. Beyond its primary applications, researchers have also used pyrite for energy applications due to its unique semiconducting nature. Pyrite has a small band gap of (0.8–0.95 eV) and a high electron carrier mobility of 360 cm²V⁻¹s⁻¹¹³. Its crystal structure has a close resemblance to sodium chloride, where iron and sulphur ions are replaced with sodium and chloride ions. FeS₂ nanoparticles are employed in diverse applications, including battery electrodes¹⁸, catalytic processes¹⁹, and optical applications²⁰. They have synthesised such nanoparticles using a variety of physical and chemical methods such as spray pyrolysis, template-directed methods and solvothermal methods by employing chemical precursors. These methods are often tedious and most importantly they are missing the opportunity to explore the natural properties of earth-abundant pyrite. Moreover, it's difficult to control the stoichiometry and crystallinity of the products by using these methods and end up getting unwanted by-products such as FeS and Fe₃S₄. It is noteworthy to say that researchers have reported the synthesis of quantum dots, and nanowires using FeS₂ however very few have reported the synthesis of 2D-FeS₂. Theoretical studies have shown that the exfoliation energy of FeS₂ (58meV/atom) is similar to that of exfoliation energy for layered TMDs such as WS₂ (56meV/atom) and MoS₂

(72meV/atom) indicating the possibility of synthesising 2D-FeS₂ nanoparticles by liquid phase exfoliation (LPE)²¹.

In this work, we employed the LPE method for synthesising 2D-FeS₂ using the ultrasonic probe sonication method. Isopropyl alcohol is used as the exfoliating medium because of its high boiling point (82.5°C) and low toxicity when compared to other solvents such as NMP. In addition to that the obtained nanoparticles dispersion were easily dried in ambient conditions without affecting the chemistry of the material. Moreover, the scale of production via the LPE method is quite high when compared to methods like mechanical exfoliation and chemical vapour deposition (CVD) methods. The structural and morphological studies of the obtained 2D-FeS₂ were analysed using microscopic and spectroscopic studies. Pyrite being a narrow bandgap semiconductor, it is possible to make a Schottky device by simply making a metal contact which can act like a small signal diode for Radiofrequency applications. A device for RF energy harvesting was thus fabricated using the drop-casting method at ambient conditions, employing a Ti/2D-FeS₂/ITO configuration. The drop-casting method is more profitable and easier because the dispersion containing 2D nanoparticles can be coated on any substrate of interest. Whereas in methods like mechanical exfoliation and CVD, it is tedious to transfer the material to the substrate and there is a need for specific substrates and conditions for growing the material which is costly and time-consuming. A variety of electrical measurements of the device showed a very low turn-on voltage of 0.18V which is ideal for Radio frequency applications. RF studies showed the device's performance in frequency modulation (FM) broadband and very high-frequency (VHF) bands. In addition to experimental studies, we also performed density functional theory (DFT) studies revealing the existence of giant Stark effect (GSE) analogous to the conventional Stark effect observed in atomic orbitals in 2D-FeS₂ layers²², which is one of the major reasons for RF response of 2D-FeS₂. The alteration in the electronic band structure of the material induced through the GSE sheds new light on RF energy harvesting using 2D materials.

2 Result and Discussion

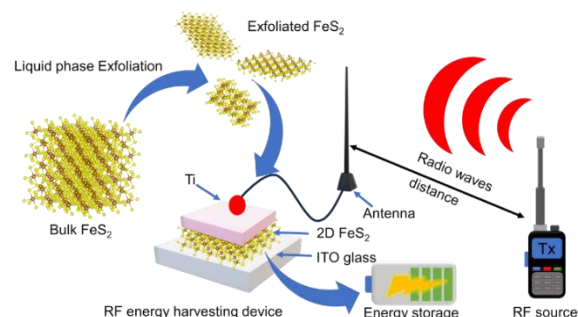


Figure 1: Schematic representation of exfoliation of bulk to 2D-FeS₂ and its application for RF energy harvesting

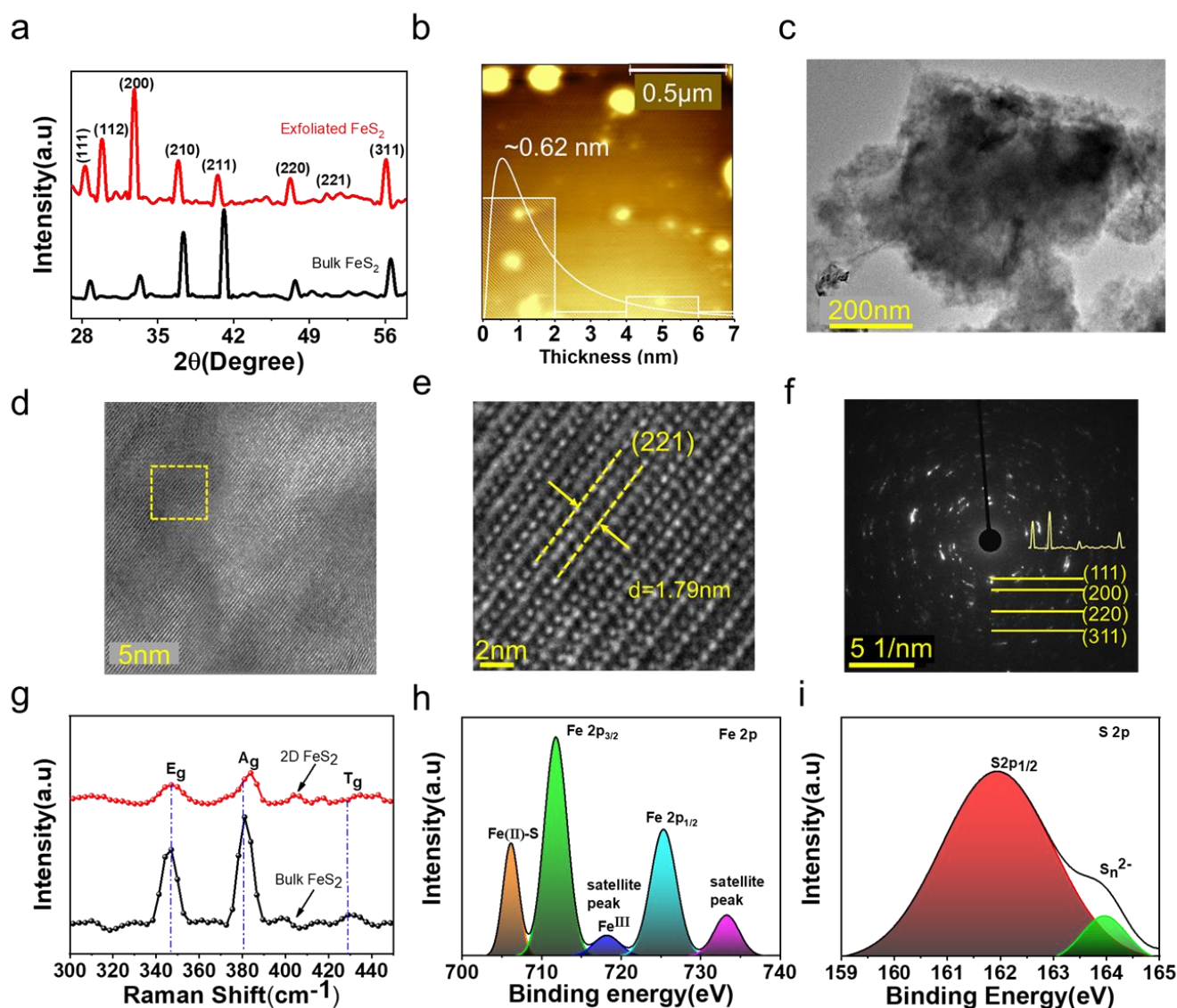


Figure 2: (a) XRD pattern of bulk and exfoliated FeS₂, (b) AFM image with thickness profile of 2D-FeS₂ (c-d) Bright field HRTEM image of 2D-FeS₂, (e) Zoomed in view of marked section from Figure 2d, (f) SAED pattern of 2D-FeS₂ showing (111) (200) (220) (311) planes, (g) Raman spectra of bulk and 2D-FeS₂ with various vibrational modes and (h, i) XPS spectra of 2D-FeS₂ showing Fe 2p and S2p binding energy plots.

Figure 1 illustrates the schematic depiction of the 2D-FeS₂ synthesis process employing the liquid-phase exfoliation technique, followed by the fabrication of an RF energy harvesting device designed for diverse applications. The phases present in bulk and the exfoliated samples were analysed and compared using XRD analysis, depicted in **Figure 2a**. Cubic FeS₂ crystals have the space group $Pa\bar{3}$ and the lattice parameters $a=b=c=5.39\text{\AA}$, corresponding to the ICSD 53935. X-ray diffraction analysis of bulk FeS₂ reveals an intense peak in the (211) plane, while that of an exfoliated sample lies in the (200) plane. The peak shift towards lower 2θ in the exfoliated sample is due to lattice expansion in the crystal. This increase in lattice expansion is an indication of the formation of FeS₂ nanoparticles. No other phases were detected from XRD analysis. AFM analysis was performed to verify the thickness of the exfoliated FeS₂. The thickness profile and AFM image of the FeS₂ sample are shown in **Figure 2b**. From the AFM analysis, the

obtained sample has an average thickness of 0.62 nm (1-2 layers), which justifies the formation of 2D-FeS₂. Analyses were performed to investigate the morphology of the 2D-FeS₂ to understand the obtained nanoparticles better. From **Figure 2c**, the obtained 2D-FeS₂ has a more irregular flake-like morphology with an average lateral length of ~0.9 μm . A deep understanding of the 2D flakes was analysed using HRTEM. From **Figure 2d** it is observed that there is an even arrangement of atoms. The zoomed-in HRTEM (**Figure 2e**) image shows a precise arrangement of atoms along the (221) plane, and the lattice spacing was found to be 1.79 nm, which is in good agreement with the (221) plane, as seen in the XRD analysis of 2D-FeS₂. The SAED pattern of FeS₂ nanocrystals is depicted in **Figure 2f**. The circular ring pattern with indexing and XRD analysis supports the overall polycrystalline nature of the obtained 2D-FeS₂.

The vibrational states of bulk and 2D-FeS₂ were analysed using Raman spectroscopy. **Figure 2g** shows that the Raman spectra of both bulk and 2D-FeS₂ show the double regeneration (E_g), symmetric mode (A_g), and stretching (T_g) modes. The E_g mode corresponds to S_2 liberation, and A_g corresponds to the in-phase stretching vibration of the S-S dimer. The T_g mode indicates coupled liberation and stretching modes^{23,24}. In the case of 2D-FeS₂, a peak position to the right is shifted by 2 cm⁻¹. This is probably due to the generation of compressive strain in the material due to exfoliation. No other vibrational modes are present, indicating the absence of other phases. The chemical oxidation states of 2D-FeS₂ were analysed using XPS. **Figure 2(h,i)** shows XPS plots of Fe 2p and S 2p. The Fe 2p is further resolved to Fe 2p_{1/2} (711.6 eV) and Fe 2p_{3/2} (725 eV)²⁵. In addition to this, satellite peaks are observed at binding energies of 718.2 eV and 733.2 eV. The peak at 706.2 eV indicates Fe (II)-S. In the case of S 2p, a broad peak at 162 eV corresponds to the S (2p_{1/2}) core level of S²⁺ associated with the formation of FeS₂²⁶. The absence of any additional peaks indicates the purity of the sample after exfoliation. Hence, the above studies confirm the formation of stable 2D FeS₂.

Electrical studies were performed to understand the electronic nature of 2D-FeS₂. Hall effect measurements elucidated the semiconducting nature of 2D-FeS₂, revealing it as a p-type semiconductor with a carrier concentration of $3.74 \times 10^{18} \text{ cm}^{-3}$ and carrier mobility of $5.81 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$. Additional electrical studies were conducted to determine the formation of the Schottky diode. Carrier mobility is one crucial factor determining Schottky device characteristics, such as high-frequency response and operating speed. **Figure 3(a, b)** depicts the device configuration graphically and pictorially. **Figure 3c** shows the optical image of the Ti metal contact with a diameter of 1 mm and a contact area of 0.785 mm^2 . **Figure 3d** shows a cross-sectional SEM image revealing the coating thickness of $\sim 25 \text{ }\mu\text{m}$ by drop-casting 2D-FeS₂ onto ITO-coated glass. An FESEM image of 2D-FeS₂ with particle size distribution is given in Supplementary Figure S2. The coating comprises FeS₂ nanoparticles with an average particle size of 260 nm. The work function of FeS₂ (5.45 eV) is higher than that of Ti (4.33 eV), which satisfies the conditions necessary for the establishment of a Schottky junction ($\Phi_{\text{FeS}_2} > \Phi_{\text{Ti}}$)^{27,28}. Current-voltage (I-V) analyses were conducted to substantiate the Schottky

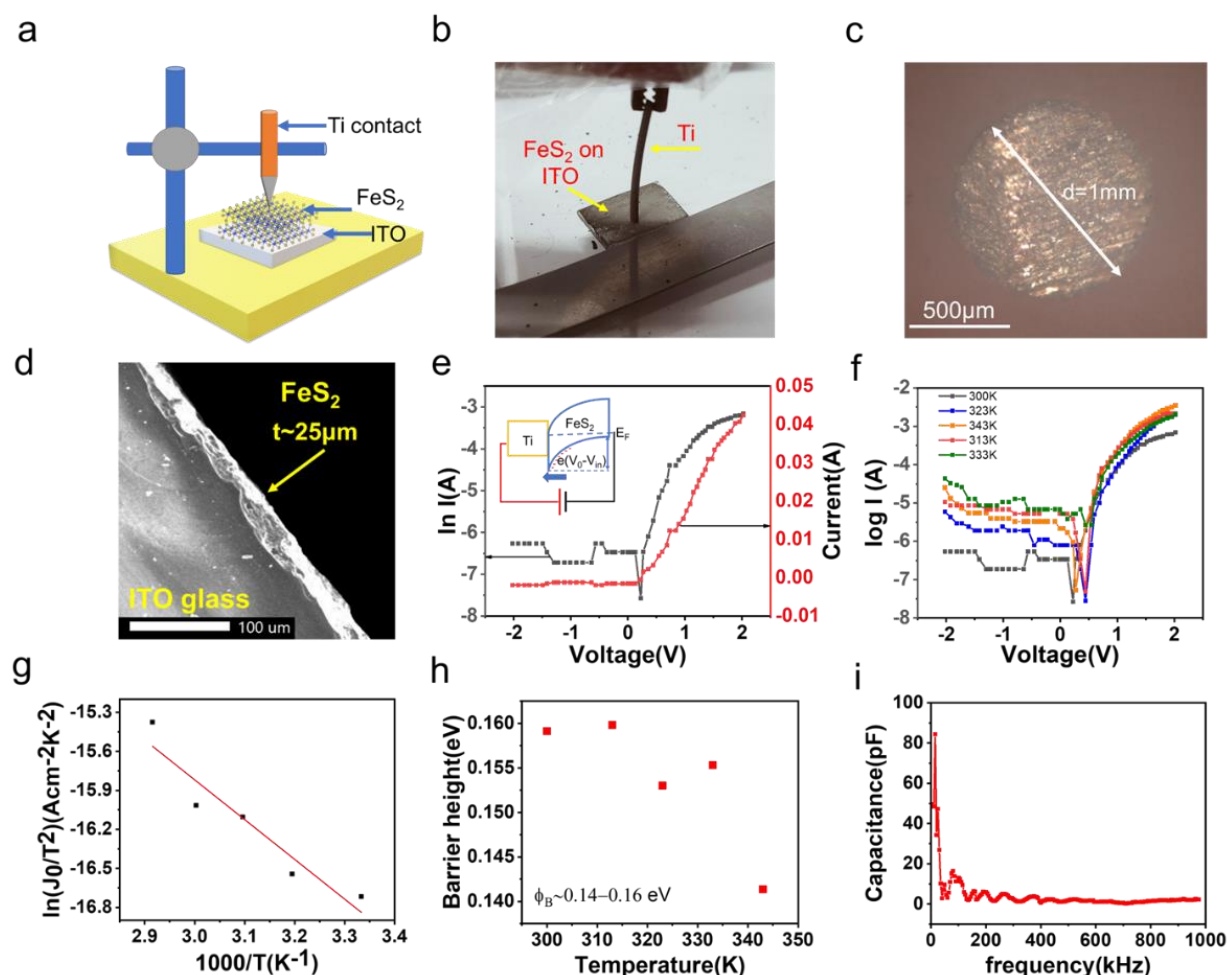


Figure 3: (a) Graphical image of Ti/2D-FeS₂/ITO device setup; (b) Pictorial image of device setup showing Ti/2D-FeS₂/ITO contacts; (c) Optical image of Ti metal contact; (d) SEM cross-sectional image showing the thickness of FeS₂ coating; (e) Current-voltage characteristics of Ti/2D-FeS₂/ITO device; and (f) Temperature-dependent I-V characteristics of Ti/2D-FeS₂/ITO device with inset showing energy band diagram; (g) Richardson plot of $\ln(J_0/T^2)$ versus $1000/T$ (h) Barrier height versus temperature plot (i) junction capacitance measurement at various frequencies of Ti/2D-FeS₂/ITO device

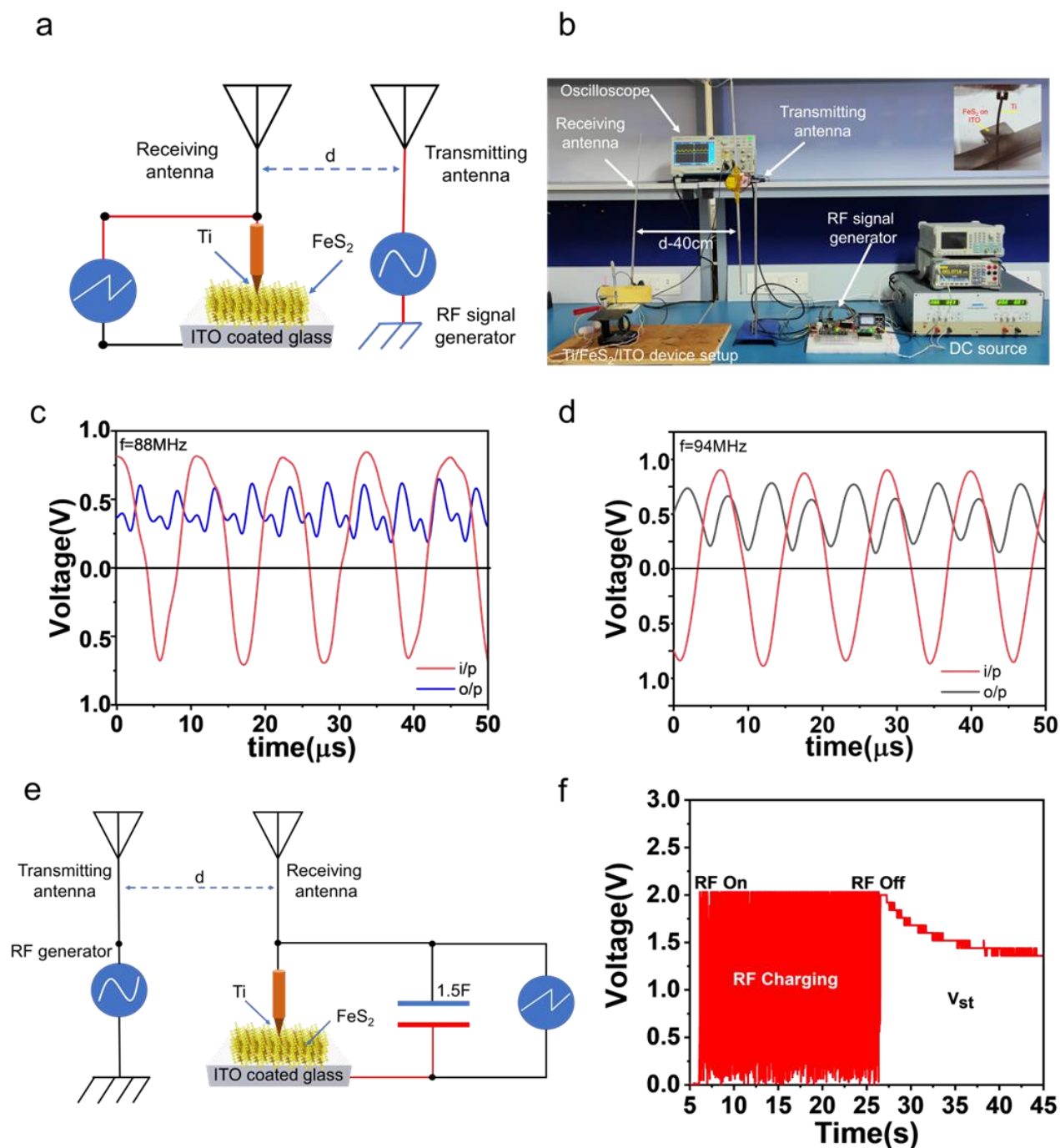


Figure 4: (a) Schematic representation of the experimental setup showing Ti/2D-FeS₂/ITO device; (b) Photographic image of the experimental setup with inset showing Ti/2D-FeS₂/ITO contacts (c, d) Half wave rectification behaviour of the device with FM broadcast frequencies 88MHz and 94MHz. Here, red indicates the input signal, and blue and black indicate the output signal (e) Schematic representation of wireless charging of supercapacitor using Ti/2D-FeS₂/ITO device (f) RF charging and discharging plots of the supercapacitor (V_{st} -stored voltage).

characteristics of both bulk and 2D-FeS₂ devices. Bulk FeS₂ shows a linear behaviour with a small rectifying nature, which is not ideal for rectifier applications (Figure S3). **Figure 3e** depicts the I-V characteristics of the Ti/2D-FeS₂/ITO device. The nonlinear increase in the current during the forward bias operation signifies rectifying behaviour, confirming the formation of a Schottky junction. The device has an on-off ratio of 10⁵ cycles, ideal for high-frequency signal and RF

applications. In addition to the aforementioned experiments, we have also conducted measurements on the thickness-dependent I-V characteristics of 2D-FeS₂. Remarkably, as the thickness increases, the turn-on voltage shows a corresponding increase, and intriguingly, the device ceases to display any rectification behaviour at higher thicknesses. The thickness-dependent I-V characteristics have been depicted in **Supplementary Figure S4**. Consequently, we have opted for a

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25 μm thickness FeS_2 coating for further measurements for better rectification. Temperature-dependent I-V studies (**Figure 3f**) were also performed to calculate Schottky barrier height from the Richardson plot (**Figure 3g**). The Schottky barrier height is calculated using the following equation ¹³

$$\Phi_B = \frac{kT}{q} \ln \left(\frac{A^* AT^2}{I_0} \right) \quad (1)$$

Where Φ_B is the barrier height, k is the Boltzmann constant, T is the temperature, q is the charge of electrons, A^* is the Richardson constant, A is the area of cross-section, and I_0 is the reverse saturation current. The calculated barrier height falls in the range of 0.14–0.16 eV, as shown in **Figure 3h**. Also, it is observed that as temperature increases, the barrier height lowers, which could be due to the tunnelling of thermally activated electrons into the semiconductor depletion region. The reduction in the metal-semiconductor junction contributes to a decrease in the Schottky barrier height, with the observed low values attributed notably to Fermi-level pinning at the interfaces of Ti/2D- FeS_2 ²⁹. Theoretically, a lower Schottky barrier height is recommended for RF applications, as the lower energy of radio waves facilitates the easy excitation of electrons, enabling efficient current flow ¹³. The capacitance of the device is also analysed to assess the impact of capacitance on the device's performance. **Figure 3i** shows capacitance values at various frequencies, and at higher frequencies, the junction capacitance remains almost constant with an average capacitance of $\sim 3\text{pF}$.

By establishing a Schottky junction, we describe an experimental demonstration of energy harvesting employing a fabricated device that can wirelessly capture and convert RF signals to appropriate electrical energy. **Figure 4 (a, b)** shows the schematic representation and photographic image of the lab-made experimental setup. A lab-made RF setup consists of an RF signal generator, RF amplifier, DC source and a dipole antenna. A separation distance of 40 cm was maintained between the transmitter and receiver antennas, with the recording of input and output waveforms accomplished using a dual-channel oscilloscope. Our interest is to check RF response in FM broadband frequencies. Therefore, we opted for two FM broadband frequencies, namely 88 MHz and 94 MHz, with an amplitude of 0.8 V and RF power of 20 dBm (100 mW), as they are presently not used by our nearby FM stations. **Figure 4(c, d)** shows the input and output waveform of the RF signal to the device. It is visible that the output waveforms appear in a positive cycle, indicating the rectification behaviour of the device. As frequency increased, the ripples in the output waveform decreased. This observation aligns with the inverse relationship between frequency and ripple amplitude, suggesting a smoother waveform at higher frequencies. Ripples are expected to persist in low frequencies as no supplementary RC circuit has been incorporated. All the measurements were done at room temperature conditions. These results justify the Schottky diode behaviour of Ti/2D- FeS_2 /ITO devices.

Subsequently, the charging of a supercapacitor utilising an RF energy harvesting device in the FM broadcast band is illustrated, as depicted in **Figure 4e**. We connected a

supercapacitor of 1.5 F to the output of the device to store the voltage generated from the device. A load (LED) is connected across the capacitor for the discharging study. The device received an RF input at 94 MHz with a signal amplitude of 2V and RF power of 20 dBm (100 mW) for 20 seconds, leading to the recording of the resulting stored voltage (V_{st}), as illustrated in **Figure 4f**. The RF input signal turned off after 20 seconds, and it stopped charging the capacitor. Remarkably, the supercapacitor attained a voltage storage level of 2 V within 20 seconds, and this capacity can be further augmented by prolonging the duration of RF charging and increasing RF input power. A gradual decrease in the voltage after turning off the RF is due to the discharging of the capacitor through the load. This shows the potential of wireless RF charging using Ti/2D- FeS_2 /ITO devices. **Supplementary video V1** shows the charging and discharging of a supercapacitor when an RF signal is applied. Based on these findings, we infer that FeS_2 is a promising material for RF-powered supercapacitor charging.

By confirming RF studies in FM broadband and expecting further high-frequency response, we performed an in-situ demonstration of wireless RF energy harvesting using a handheld walkie-talkie. **Figure 5 (a, b)** shows the schematic and pictorial representation of the experimental setup for demonstrating RF energy harvesting. A handheld walkie-talkie of 200 mW power with operating frequencies of 130–176 MHz was used as the RF source. **Figure 5c** illustrates the input and output waveforms at 150 MHz, revealing a distinct DC behaviour in the output signal. Hence, we proceeded to investigate RF energy harvesting in the above frequencies. The output voltage and power from the device is measured across a resistor R_L 220 Ω at various distances and frequencies, as shown in **Figures 5 (d, e)**. It is observed that the voltage and power generated decrease with an increase in distance, which is a general observation of the attenuation of electromagnetic waves with distance. From power calculations, the efficiency of the device was calculated at various frequencies, as shown in **Figure 5e**. The ratio of power generated to power input was used to calculate efficiency. The calculations indicate that the device exhibits an efficiency of approximately 30% at 155 MHz, with a notable decrease in efficiency observed at 170 MHz. By using the measured values of junction capacitance C_j (3pF) and resistance R_s (310 Ω), the cut-off frequency is calculated using the following formula.

$$f_{\text{cutoff}} = \frac{1}{2\pi R_s C_j} \quad (2)$$

The obtained cut-off frequency value is $\sim 171\text{MHz}$, which matches our experimental studies. So, any further increase in frequency may not produce voltage from the device, limiting its performance up to 170 MHz. Such a cut-off frequency is desirable because most ambient RF energy sources will have frequencies in a 3–300 MHz domain. The efficiency of the device can be extended by adding a suitable impedance-matching network and proper antennas. The **supplementary video V2** demonstrates energy harvesting from a handheld walkie-talkie by connecting an LED across the fabricated device. In order to verify that the Schottky junction is formed between Ti and 2D-

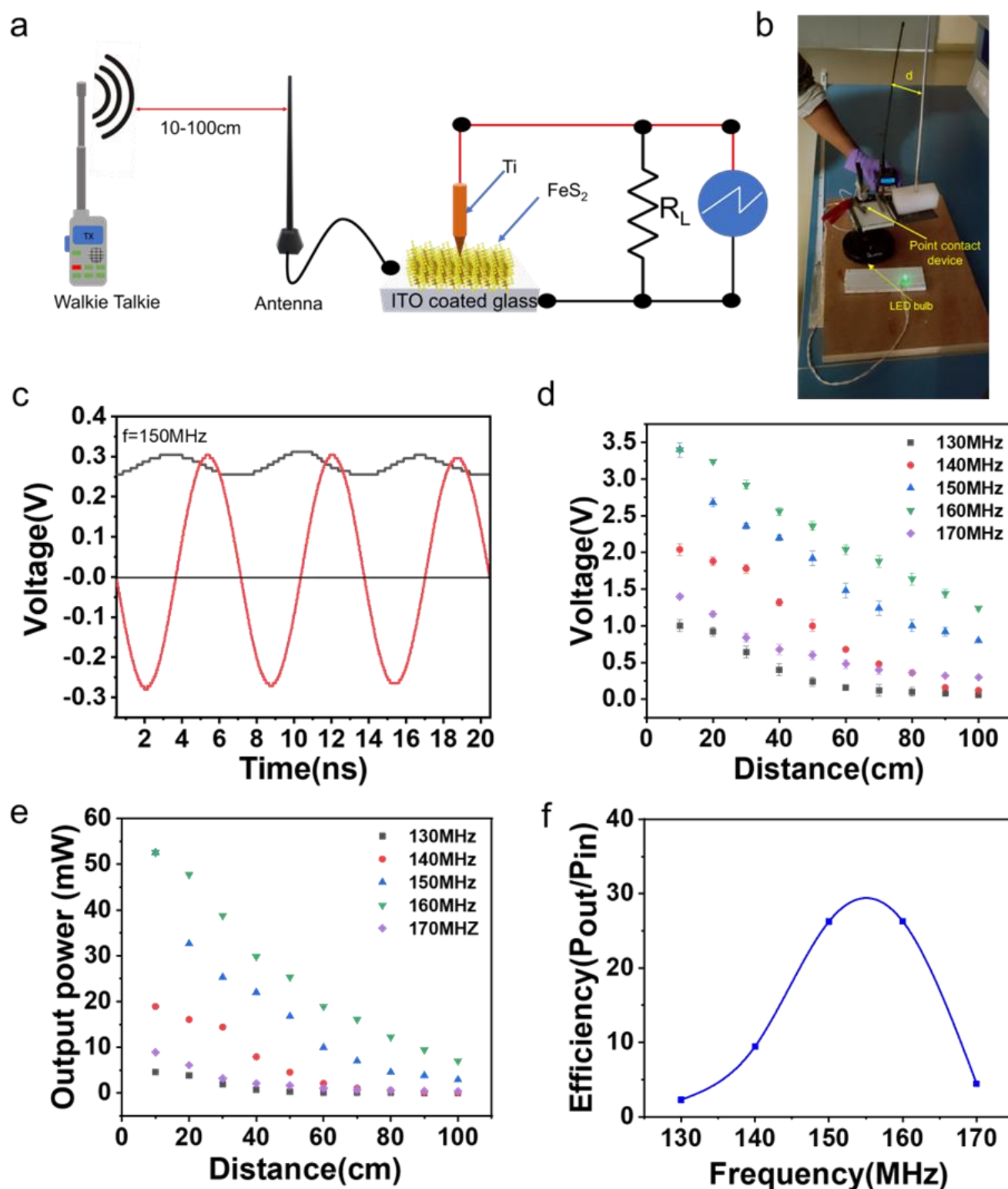


Figure 5: (a) Schematic image of the experimental setup for RF energy harvesting using Ti/2D-FeS₂/ITO device with external load R_L , (b) Pictorial representation of experimental setup; (c) Input and output waveforms of RF signal given to device at 150 MHz (d) Output voltage versus distance plots at various frequencies, (e) Output power versus distance plots at various frequencies and (f) Efficiency versus frequency plots at various frequencies

FeS₂, we fabricated a Ti/ITO device without 2D-FeS₂ and measured IV and RF responses. We found no formation of a Schottky junction and no RF response in the absence of FeS₂.

Supplementary Figure S5 shows the I-V and RF responses of the Ti/ITO configuration.

The electronic characteristics of 2D-FeS₂ hold considerable influence over device properties, notably the turn-on voltage

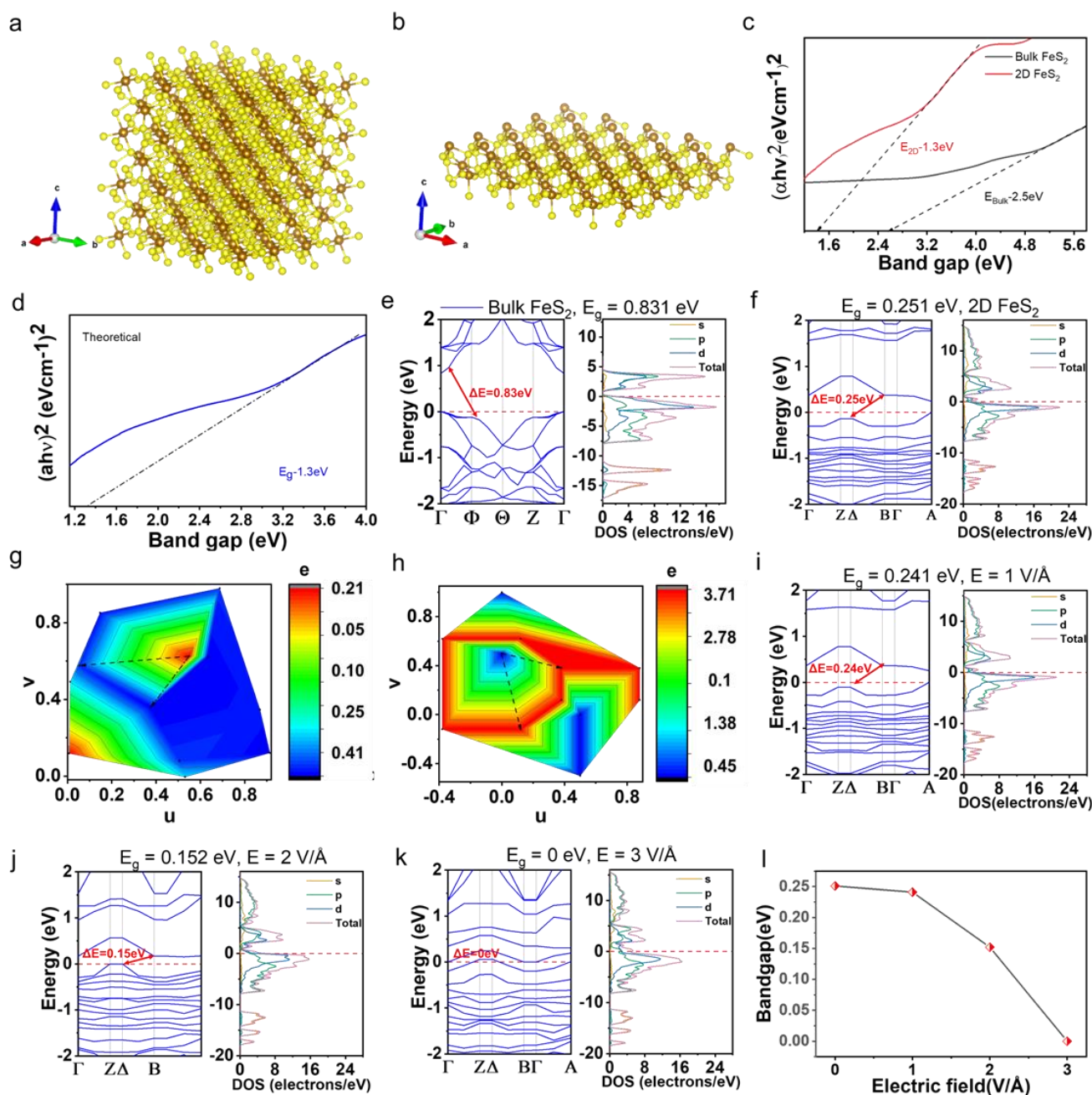


Figure 6: (a, b) Representation of bulk FeS₂ crystal structure and (1 0 0) surface; Iron atoms representing in brown colour, and sulfur in yellow colour; (c) Optical bandgap (experimental) (d) Optical bandgap (theoretical); (e) Band structure of bulk showing minima at Γ point for 0.831 eV (f) Band structure of (1 0 0) surface showing minima at an end for 0.241 eV; (g, h) Charge distribution contour graph of (g) bulk (h) 2D (1 0 0) plane; (i-k) effect of electric field variation on FeS₂(1 0 0) surface band structure at $E = 1$ V/Å, $E = 2$ V/Å and $E = 3$ V/Å and (l) Variation of bandgap with electric field

(V_t) and barrier height (Φ_B). These parameters, crucial for device performance, are inherently linked to electronic properties such as band gap and electron affinities. To better understand these complex electronic properties and how they affect device behaviour, we therefore performed Density Functional Theory (DFT) studies on bulk and 2D-FeS₂. After variable cell relaxation of FeS₂, bulk FeS₂ was determined to have a cubic structure with $a = 5.361$ Å, and Pa-3 space group. Iron atoms occupy an octahedral position, and sulfur occupies a tetrahedral position, similar to the experimental observations, as shown in **Figure 6a**. In 2D-FeS₂ with a (1 0 0) plane, the core of the crystal structure

is similar to that of bulk, while the edge atoms are crystallised in tetrahedron iron atoms, as depicted in **Figure 6b**. A stable 2D-FeS₂ crystal structure shows compressive lattice strain, with lattice parameters $a = 5.3167$ Å, and $b = 5.4484$ Å, which was also observed in experiment results. Calculated vibration spectroscopy for the obtained crystal structure also shows no imaginary values, which confirms its dynamic stability.

Spectroscopic analyses were conducted to establish a correlation between the DFT studies of FeS₂. Experimental UV-vis spectroscopy results confirm a decrease in the optical band gap from 2.5 eV (bulk) to 1.3 eV (2D). Notably, this experimental

finding is consistent with the optical band gap of 2D-FeS₂ determined through DFT analysis, as illustrated in **Figure 6 (c, d)**. This alignment underscores the agreement between theoretical calculations and experimental observations, enhancing our understanding of the electronic properties of FeS₂. From the DOS plot, the electronic bandgap of bulk and 2D-FeS₂ is 0.831 eV and 0.251 eV, respectively, as depicted in **Figure 6 (e, f)**. The polarisation mechanism in bulk and 2D-FeS₂ is shown in **Figure 6 (g, h)**. Bulk FeS₂ shows an even distribution of the charge because of the cubic crystal symmetry, whereas 2D shows the localisation of the charge. Considering an electric dipole, $\vec{P} = q_{\text{net}}\vec{d}$, where q_{net} is the net charge between two atoms, and d is the distance separated. In bulk FeS₂, \vec{P}_1 and \vec{P}_2 are two electric dipoles (dashed lines) in two different directions, but the resultant is zero due to the cubic crystal symmetry. But in the case of 2D-FeS₂, the resultant is non-zero, \vec{P}_3 and \vec{P}_4 has values in 1.86 eÅ and 0.744 eÅ in the x-direction. This localisation effect and anisotropic charge surface create surface polarisation, decreasing the band gap in 2D-FeS₂. The same has been observed in 2D TDMC, and researchers have shown that applying an external transverse field can reduce the band gap that results from the semiconductor-to-metal transition³⁰ The electric field can alter the chemical potential of electrons, allowing them to delocalise depending on the polarity of the charge applied. This induces an anisotropy in the electronic structure, which breaks the inversion symmetry, leading to Spin-orbit (SO) splitting in the valence and conduction band. This effect is called the Giant-Stark effect (GSE) and describes a phenomenon similar to the standard Stark effect for atomic orbitals. The GSE is based on the fact that transverse electric fields are responsible for mixing electronic states, leading to a splitting of the electronic bands. The quantum-confined Stark effect (QCSE)^{31–34} describes a striking alteration in the energies of quantum states induced by an electric field in low-dimensional materials. By applying the electric field along the confinement direction of a quantum well or other nanostructure, a large electric field can cause a massive shift of exciton states. The energy of the constituent electron states in the conduction bands and the hole states in the valence bands change in opposite directions, causing the band gap to shrink proportionally to the electric field. When an electric field is applied, the wave functions of the electron and hole within the confined structure move in opposite directions, causing the exciton binding energy to be suppressed. In light of this, we investigated the impact of the external electric field on the band structures of 2D-FeS₂.

Figure 6 (i-k) presents the outcomes of our computational analysis elucidating the band structure of 2D-FeS₂ under the influence of external electric field strength of $E = 1, 2$, and 3 V/Å . The remarkable discovery is that the band gap changes from its original value of 0.241 eV (in the absence of an external electric field) to a state approximating metallic behavior at $E = 3 \text{ V/Å}$. Specifically, the lower conduction band (CB) exhibited a discernible upward shift of 0.01 eV, resulting in a band gap of 0.251 eV when subjected to an electric field of $E = 1 \text{ V/Å}$. Further, with an increased electric field strength of $E = 2 \text{ V/Å}$, the band gap was subsequently reduced to 0.152 eV. Notably,

metallic band overlap was observed at $E = 3 \text{ V/Å}$. Notably, electric fields at or below $E \leq 1 \text{ V/Å}$ led to an upward displacement of the lower conduction band and heightened confinement of available states near the Fermi level. In contrast, electric fields at or exceeding $E \geq 1 \text{ V/Å}$ induced an upward displacement of valence bands within excited orbitals, attributed to the Giant-Stark effect (GSE). **Figure 6l** depicts the decrease in the bandgap with an increase in electric field. Similar observations have been made for bilayer TMC, where the bandgap decreases linearly with the electric field³⁵. Consequently, the application of a stronger electric field has the potential to modulate the band gap significantly.

The impact of GSE on lowering of bandgap can affect the Schottky barrier height at the Metal-semiconductor junction. The Schottky barrier height of a p-type semiconductor is defined as

$$\Phi_B = (E_g + \chi) - \Phi_M \quad (3)$$

Where Φ_m the metal work function in eV, χ is the electron affinity, and E_g is the bandgap. From the above equation, it is clear that electron affinity increases as the band gap decreases, which in turn lowers the Schottky barrier height³⁶. A lower Schottky barrier height will result in a lower built-in potential by the following equation.

$$eV_0 = \Phi_B - (E_c - E_F) \quad (4)$$

Where E_c is the energy of the conduction band, and E_F is the fermi level. The built-in potential is calculated using the following equation.

$$V_0 = E_g + \chi - \Phi_M \quad (5)$$

The derived equations indicate a built-in potential of approximately 0.17 V for the device, closely aligned with its turn-on voltage obtained from **Figure 3e**. Equations (4) and (5) show that the built-in potential decreases in direct proportion to the Schottky barrier. This suggests that a lower input voltage is sufficient for electrons in the conduction band to overcome the potential barrier and allow current to flow. This relationship directly leads to a lower diode turn-on voltage, which makes the device more sensitive to low-powered RF signals. Experimental studies substantiate this enhancement in sensitivity. We have performed thickness-dependent I-V characteristics as shown in **Supplementary Figure S4** and observed that as thickness increased, the turn-on voltage was increasing, possibly due to the annihilation of GSE with the thickness of FeS₂ coatings. On the other hand, studies on bulk FeS₂ crystals, as shown in **Supplementary Figure S3**, also indicate inadequate rectification and a high turn-on voltage. These findings justify the unique application of GSE-induced 2D materials for RF applications.

An overview of reported materials for RF energy harvesting is provided in **Supplementary Table 1**. It has been reported that 2D materials with RF energy harvesting properties include MoS₂, MoSe₂, WSe₂, and Si. However, they are synthesised using expensive and time-consuming methods like Atomic Layer Deposition photolithography, electron beam lithography, magnetron sputtering and Plasma-Enhanced Chemical Vapor Deposition techniques. The techniques used require demanding conditions, such as high vacuum, high power, and precision requirements, which make them operationally time-consuming. Additionally, the utilisation of pristine precursor samples and

precious metals like Au and Pt for electrode deposition entails substantial costs. The reliance on the mechanical exfoliation method inherently limits scalability. These materials also require careful handling procedures because they are oxidation-sensitive. Even with all of these complex steps, it is important to note that devices made of these materials have high turn-on voltages, which limits their use to high-power radio functions like switching instead of RF energy harvesting. Furthermore, the environmental impact associated with materials like Se and Pb necessitates the exploration of eco-friendly alternatives. In addressing these challenges, FeS₂ emerges as a promising candidate, being both abundant and eco-friendly. In our research, we employed the conventional liquid phase exfoliation method to synthesise 2D-FeS₂, and simple drop-casting techniques at ambient conditions rendered the process cost-effective and time-efficient. The liquid phase exfoliation method represents a remarkable breakthrough in yielding abundant 2D-FeS₂. Additionally, because it is a p-type semiconductor with a large work function, the choice of electrode materials is extremely broad and includes easily obtained metals like Ti and Al, which makes the fabrication

and HAM radio bands; the requirement for extensive antennas or additional components like repeaters can be removed. This makes 2D-FeS₂ suitable for integration into portable devices such as laptops, computers, and electronic gadgets for RF energy harvesting. Unlike materials like MoS₂ and WSe₂, which necessitate high-power RF sources, repeaters, and high-gain antennas for effective operation, 2D-FeS₂ operates efficiently without such requirements. As shown in **Figure 7b**, its lower turn-on voltage is advantageous, allowing the conversion of low-signal RF to useful voltage. Despite the numerous benefits provided by 2D-FeS₂, one major limitation is its ability to extend RF sensitivity to higher frequencies. Investigating various metal contacts and the thickness dependencies of 2D-FeS₂ on RF sensitivity are useful approaches to take on this challenge. Interestingly, even though 2D-FeS₂ responds in commercial broadband frequencies, its potential uses go well beyond that, including high-frequency field-effect transistors, long-range RF identification sensors, and electromagnetic shielding, among other wireless technologies. In conclusion, using 2D-FeS₂ for RF energy harvesting appears to be a significant and affordable way to achieve the goal of a future powered by wireless

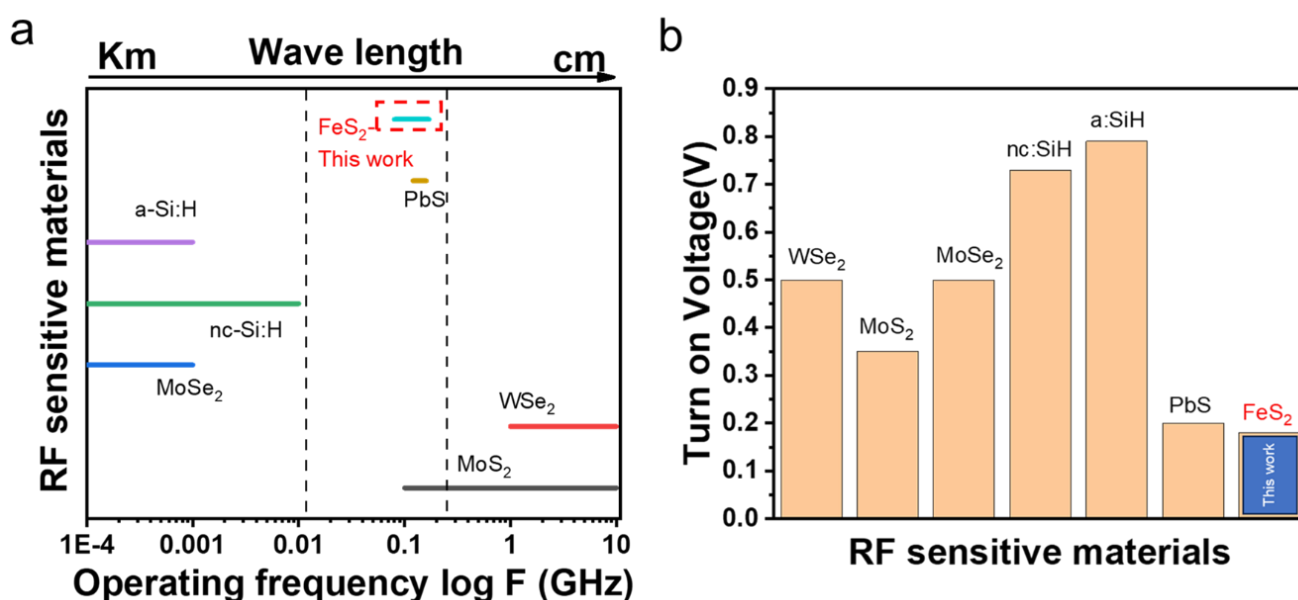


Figure 7: (a) Operating frequencies of different materials in available RF sources and (b) Turn-on voltage of various RF-sensitive materials

process extremely economical. Moreover, the adaptability of our methodology encompasses the smooth integration of flexible substrates via the simple and useful drop-casting method, augmenting practicability and accessibility. **Figure 7a** illustrates the operating frequency range of various reported materials in the radio spectrum for RF energy harvesting. For satisfactory reception of radio waves, the antennas of radio receivers should have one-quarter of their wavelength. Materials like a-Si:H, nc-SiH, and MoSe₂ operating in low frequencies will require a larger length antenna for decent reception of RF signals. This limitation poses challenges for their integration into electronic circuits for energy harvesting, particularly for portable devices. In contrast, 2D-FeS₂ operates in lower frequency RF bands such as commercial FM broadband

technology.

3. Experimental Section/Methods

3.1 Material Synthesis

2D-FeS₂ was synthesised using a liquid-phase exfoliation method. 5g of bulk FeS₂ crystals were crushed with a pestle and mortar to obtain powder, and a subsequent 4 hours of sonication in 100 mL isopropyl alcohol (IPA) solvent followed. The dispersion was allowed to settle for an hour to separate the nanoparticles from the bulk particles. The 2D nanoparticles were then separated from the rest of the dispersion by centrifugation. The 2D nanoparticle dispersion was isolated using a dropper and transferred to sample bottles for further analysis.

3.2 Characterisation

Both bulk and 2D-FeS₂ samples were characterised for structural, morphological, spectroscopic, and electronic properties. Phase analysis was done by X-ray diffraction (XRD) (Bruker D8 Advance with a Lynx eye detector using Cu-K α radiation). The morphology and atomic arrangements were analysed using scanning electron microscopy (SEM) (ZEISS Sigma) and high-resolution transmission electron microscopy (HRTEM) (advanced Titan electron microscope). The atomically-thin nature of 2D-FeS₂ was confirmed using atomic force microscopy (AFM) (Pico Scan 5100, Agilent Technologies). Vibrational modes were analysed using Raman spectroscopy (WITec, UHTS 300VIS, Germany). The chemical states of 2D-FeS₂ were analysed using X-ray photoelectron spectroscopy (XPS) (Thermo Fisher Scientific makes Nexsa base). Current-Voltage characteristics were determined using a source meter (Keithley 2450). RF studies were conducted using a lab-made RF setup consisting of an RF generator (35 MHz–4.4 GHz), an RF power amplifier, a standing wave ratio (SWR) power meter, Walkie Talkie (Baofeng UVR5R) and an oscilloscope (Tektronix 1072 B).

3.3 Device Fabrication and experimental setup

Radiofrequency (RF) energy harvesting devices can transform RF signals into usable electrical power without a biasing circuit. To fabricate the device, we created a homemade setup that consists of a substrate holder and a metal wire holder that can be adjusted to accommodate different substrate sizes and different kinds of metal contacts. As one of the contact electrodes, we used a commercially available indium tin oxide (ITO) substrate with dimensions of 1x1x0.7 cm and drop-cast 2D-FeS₂ on it while keeping the substrate temperature at 40 °C. We connected a mechanical titanium electrode of 0.758 mm² area, which can be moved up and down to adjust the contact height as the working electrode to the 2D-FeS₂ coating. A schematic representation of device fabrication using the drop-casting method is given in supplementary Figure S1. Output connections were taken from the ITO substrate and the Ti electrode. The overall configuration of the device is Ti/2D-FeS₂/ITO.

3.4 Computational Methodology

Density functional theory (DFT) simulations were carried out for the FeS₂ structure using the DMol³ code³⁷. We used the initial crystal and atomic coordinates parameters from the experimental XRD analysis for FeS₂ Bulk. A 2D-FeS₂ crystal structure was created by cleaving the (1 0 0) plane from FeS₂ Bulk and adding a 15 Å vacuum buffer separation to remove any non-bonding energy interactions perpendicular to the plane. The generalised gradient approximation (GGA) method was used in all simulations using the exchange-correlation functional by Perdew-Burke-Erzenhof (PBE)³⁸. We used a double numerical (DN) basis set, which includes a minimal basis and a second set of valence atomic orbitals. The self-consistent field (SCF) convergence criterion for electronic optimisations was 10⁻⁶ eV/atom. We used a 2 x 2 x 1 k-points mesh with all

electrons included in the calculation, and the simulation box was allowed to relax during the variable cell calculation.

4. Conclusions

In summary, we fabricated an RF energy harvesting Schottky device using Ti/2D-FeS₂/ITO configuration by drop casting method. 2D-FeS₂ was synthesized from earth-abundant pyrite ore through a liquid phase exfoliation technique. The microscopic and spectroscopic studies confirmed the stability of 2D-FeS₂. Electrical studies revealed that the device made of 25 μm film of 2D-FeS₂ has a low turn-on voltage of 0.18V and a low Schottky barrier height of 0.16eV. The role of 2D-FeS₂ on the electronic properties of the device was analyzed using density functional theory studies which revealed the contribution of the Giant stark effect in 2D-FeS₂. This shed light on the impact of lowering the band gap from bulk FeS₂ to 2D-FeS₂ which resulted in a possible lowering of turn on voltage of the device. This satisfied the criteria for the device to behave as an ideal RF energy harvesting device since a low turn-on RF voltage will be sufficient to turn on the diode. After confirming this, we proceeded with RF studies of the device in commercial FM broadband (88-108MHz) and very high-frequency band (130-170MHz) because of its easy availability in the ambient. Experimental studies revealed that the device has an overall efficiency of 30 % which can be improved by adding additional network-matching circuits to the device. Theoretical studies revealed the effect of external electric field in lowering the bandgap of 2D-FeS₂ suggesting possible future applications in field effect transistors for high-speed applications. The obtained experimental and theoretical studies show that RF energy harvesting using earth-abundant FeS₂ serves as a potential candidate for sustainable energy harvesting.

Author Contributions

Karthik R: Conceptualization, Methodology, Investigation, Writing - Original Draft, Visualization, Appu Kumar Singh: Software, Formal analysis, Shreyasi Das: Validation, Investigation, Suman Sarkar: Resources, Tarun Kumar Kundu: Writing - Review & Editing, Swastik Kar: Writing - Review & Editing, P R Sreeram: Conceptualization, Writing - Original Draft, Writing - Review & Editing, Supervision, Chandra Sekhar Tiwary: Resources, Writing - Review & Editing, Supervision, Project administration, Funding acquisition.

Conflicts of interest

There are no conflicts to declare

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